

FCC Test Report

Applicant : Shenzhen Hongshanjie Technology Co., Ltd

2/F, No.20, Jiuwei 1st Road, Jiuwei

Address : Community, Hangcheng Street, Bao'an

District, Shenzhen, China

Product Name : Wireless Charging Power Bank

Report Date : May 28, 2024









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TEST REPORT

Applicant : Shenzhen Hongshanjie Technology Co., Ltd Manufacturer : Shenzhen Hongshanjie Technology Co., Ltd

Product Name : Wireless Charging Power Bank

Test Model No. : 10052

Reference Model No. : 10053, 10054, 10055

Trade Mark : N/A

Input:

Micro: 5.0V=2.0A, 9.0V=2.0A, 12.0V=1.5A Type-C: 5.0V=3.0A, 9.0V=2.0A, 12.0V=1.5A

Lighting: 5.0V-2.0A USB cable: 5.0V-2.0A

Output:

Rating(s) Type-C: 5.0V=3.0A, 9.0V=2.2A, 12.0V=1.67A

USB-A: 5.0V= 3.0A,9.0V= 2.0A,12.0V= 1.5A

Type-C cable: 5.0V= 3.0A, 9.0V= 2.2A, 12.0V= 1.67A

Lighting cable:5.0V=2.0A Wireless:output:15W Max.

Battery Capacity: 3.8V, 10000mAh, 38.5Wh

Test Standard(s) : FCC Part 1.1310, 1.1307(b)

Test Method(s) : KDB680106 D01 RF Exposure Wireless Charging Apps v04

October 25, 2023 TCB Workshop

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 1.1307 & KDB680106 D01 & TCB Workshop, October 25, 2023 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt	Apr. 09, 2024
Jate of Receipt	ADI. 03, 2024

Date of Test Apr. 08, 2024~Apr. 28, 2024

Ella Liang

Prepared By _____(Ella Liang)

Approved & Authorized Signer

(Edward Pan)

Shenzhen Anbotek Compliance Laboratory Limited

Code:AB-RF-05-b







Revision History

Report		Description Original Issue.			Issued Date May 28, 2024			
Anv otek R	ok Pr							
k hotek	Anbotek An	otek	Anbotek	Anborek	Augotek	Anborek	Anbore	
ak abotek	Anbotek	Milbo otek	nbotek	Anbore	Am	Anbotek	Anbo	





1. General Information

1.1. Client Information

Applicant	: Shenzhen Hongshanjie Technology Co., Ltd
Address	2/F, No.20, Jiuwei 1st Road, Jiuwei Community, Hangcheng Street, Bao'an District, Shenzhen, China
Manufacturer	: Shenzhen Hongshanjie Technology Co., Ltd
Address	2/F, No.20, Jiuwei 1st Road, Jiuwei Community, Hangcheng Street, Bao'an District, Shenzhen, China
Factory	: Shenzhen Hongshanjie Technology Co., Ltd
Address	2/F, No.20, Jiuwei 1st Road, Jiuwei Community, Hangcheng Street, Bao'an District, Shenzhen, China

1.2. Description of Device (EUT)

Product Name	:	Wireless Charging Power Bank
Test Model No.	:	10052
Reference Model No.	:	10053, 10054, 10055 (Note: All samples are the same except the model number and appearance color, so we prepare "10052" for test only.)
Trade Mark	:	N/A Anbotek Anbotek Anbotek Anbotek
Test Power Supply	:	AC 120V, 60Hz for adapter, DC 3.7V battery inside
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Adapter	:	N/A nbotek Anbotek Anbotek Anbotek Anbotek Anbotek
RF Specification		
Operation Frequency	:	110.1-205kHz
Modulation Type	:	FSK Anborek Anborek Anborek
Antenna Type	:	Inductive loop coil Antenna
Antenna Gain(Peak)	:	0 dBi
Remark: 1) All of the F	RF	specification are provided by customer. 2) For a more detailed features

Remark: 1) All of the RF specification are provided by customer. 2) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.







1.3. Auxiliary Equipment Used During Test

Title Manufacturer		Model No.	Serial No.		
Apple Phone	Apple	iPhone 12	Anborek / Anbore		

1.4. Test Equipment List

o'	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
	otek	Electric and	otek Anbotek	Anbo	abotek	Anbore	in otek
	1, ek	Magnetic field	NARDA	EHP-200A	180ZX10202	Oct. 16, 2023	1 Year
	AUD	Analyzer	inport Air	-otek Anboten	Anbe	t spotek	Aupora

1.5. Measurement Uncertainty

Parameter	Uncertainty				
Magnetic Field Reading(A/m)	+/-0.04282(A/m)	rek P	anborek	Anbore.	Andhotek
Electric Field Reading(V/m)	+/-0.03679(V/m)	otek	Anbotek	Anboro	k And

1.6. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 434132

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 434132.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.







2. Measurement and Result

2.1. Requirements

According to the item 5.b) of KDB 680106 D01v04:

Inductive wireless power transfer applications that meet all of the following requirements are excluded from submitting an RF exposure evaluation.

- (1) The power transfer frequency is below 1 MHz.
- (2) The output power from each transmitting element (e.g., coil) is less than or equal to 15 watts.
- (3) A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)
- (4) Only § 2.1091-Mobile exposure conditions apply (i.e., this provision does not cover § 2.1093-Portable exposure conditions).
- (5) The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1. These measurements shall be taken along the principal axes of the device, with one axis oriented along the direction of the estimated maximum field strength, and for three points per axis or until a 1/d (inverse distance from the emitter structure) field strength decay is observed. Symmetry considerations may be used for test reduction purposes. The device shall be operated in documented worst-case compliance scenarios (i.e., the ones that lead to the maximum field components), and while all the radiating structures (e.g., coils or antennas) that by design can simultaneously transmit are energized at their nominal maximum power.
- (6) For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well. For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested.







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Limits For Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)					
(A) Limits for Occupational/Controlled Exposures									
0.3-3.0	614	1.63	*(100)	6					
3.0-30	1842/f	4.89/f	*(900/f ²)	6					
30-300	61.4	0.163	1.0	6					
300-1500	1	1	f/300	6					
1500-100,000	1	1	5	6					
	(B) Limits for Genera	l Population/Uncontrolle	ed Exposure	ę-					
0.3-1.34	614	1.63	*(100)	30					
1.34-30	824/f	2.19/f	*(180/f ²)	30					
30-300	27.5	0.073	0.2	30					
300-1500	1	1	f/1500	30					
1500-100,000	1	1	1.0	30					

F=frequency in MHz

RF exposure compliance will need to be determined with respect to 1.1307(c) and (d) of the FCC rules. The emissions should be within the limits at 300kHz in Table 1 of 1.1310(use the 300kHz limits for 150kHz:614V/m,1.63A/m).

2.2. Test Setup

- 1) H-field data are taken along all three axes the device, from 0 cm to 20 cm, in 2 cm minimum increment measured from the edge of the device, with one axis coincident with the axis of the main coil.
- 2) "Large size" probes may prevent the measurement of E- and/or H-fields near the surface of the radiating structure (e.g., a WPT source coil), as in the example shown in Figure 1.

If the center of the probe sensing element is located more than 5 mm from the probe outer surface, the field strengths need to be estimated through modeling for those positions that are not reachable. The estimates may be done either via numerical calculation, or via analytic model: e.g., approximated formulas for circular coils, dipoles, etc., may be acceptable if it is shown that the model is applicable for the design parameters considered. A typical example is the use of a quasi-static approximation formula for a low-frequency magnetic field source.

These estimates shall include points spaced no more than 2 cm from each other. Thus, in the example of Figure 1, at least the estimates at 0 cm2 and 2 cm are required, while only one point would not be sufficient. In addition, the model needs to be validated through the probe measurements for the two closest points to the device surface, and with 2-cm increments, as indicated in Figure 1. In that example, the same model must also be applied to the 4 cm and 6 cm positions, and then compared with the measured data, for validation purposes. The validation is considered sufficient if a 30% agreement

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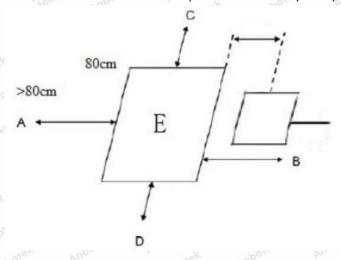


^{*=}Plane-wave equivalent power density



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between the model and the (E- and/or H-field) probe measurements is demonstrated. If such a level of agreement cannot be shown, a more accurate model (and/or a smaller probe) shall be used.



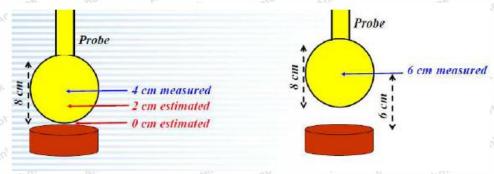


Figure 1

2.3. Test Procedure

- 1) The RF exposure test was performed in anechoic chamber.
- 2) The measurement probe was placed at required test distance (from 0 cm to 20 cm, in 2 cm minimum increment) which is between the edge/top surface of the charger and the center of the probe. and the measurement probe was placed at required test distance 15cm and 20cm which is between the edge of the charger and the geometric center of probe.
- 3) The highest emission level was recorded and compared with limit as soon as measurement of each points (A, B, C, D, E) were completed. (A is the right, B is the back, C is the left, D is the front, and **E** is the **top** side.)
- 4) The EUT was measured according to the dictates of TCB Workshop, October 25, 2023 and KDB 680106 D01 v04.

Remark;

The EUT's test position A, B, C, D and E is valid for the E and H field measurements.







2.4. Test Result

- 2.4.1. Equipment Approval Considerations item 5.b of KDB 680106 D01 v04
- (1) The power transfer frequency is below 1 MHz.
- The device operate in the frequency range 110.1-205kHz.
- (2) The output power from each transmitting element (e.g., coil) is less than or equal to 15 watts.
 - The maximum output power of the primary coil is 15W.
- (3) A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)
- The surfaces of the transmitter and client device enclosures is in physical contact.
- (4) Only § 2.1091-Mobile exposure conditions apply (i.e., this provision does not cover § 2.1093-Portable exposure conditions).
 - The EUT is a portable exposure conditions
- (5) The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1. These measurements shall be taken along the principal axes of the device, with one axis oriented along the direction of the estimated maximum field strength, and for three points per axis or until a 1/d (inverse distance from the emitter structure) field strength decay is observed. Symmetry considerations may be used for test reduction purposes. The device shall be operated in documented worst-case compliance scenarios (i.e., the ones that lead to the maximum field components), and while all the radiating structures (e.g., coils or antennas) that by design can simultaneously transmit are energized at their nominal maximum power.
 - Conducted the measurement with the required distance and the test results please refer to the section 2.4.
- (6) For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well. For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested.
 - The EUT is one radiating structure.







2.4.2. Environmental evaluation and exposure limit according to FCC CFR 47 part 1, 1.1307(b), 1.1310

Temperature: 25.8°C		Relative Humidity:	51 %		
Pressure:	101 kPa	Test Voltage:	DC 3.7V battery inside		

Between the edge/top surface of the charger and the center of probe

E-Field St	Pv.		rtop surie	7.60				- M	
Test distance	Battery power	Test Position A	Test Positio n B	Test Positio n C	Test Positio n D	Test Positio n E	Test Positio n F	Referen ce Limit (V/m)	Limits Test (V/m)
Anbo.	r sotel	Anbo	EUT Base	e support i	nput + Sta	andby	- /c	botek	Anbore
Anbore be	1%	0.498	0.588	0.518	0.508	0.618	0.657	307	614°
0cm	50%	1.478	1.958	1.418	1.578	1.738	1.713	307	614
unbotek	99%	2.492	2.942	2.522	2.482	2.982	2.919	307	614
Anbotek	EUT Base s	upport inpu	ıt + iPhon	e 13 opera	ating (10%	electric q	uantity wo	rst case)	Anbotek
Aupoter	1%	0.415	0.495	0.415	0.405	0.525	0.548	307	614
0,2,4cm	50%	1.463	1.893	1.573	1.583	1.683	1.714	307	614
otek Ar	99%	2.422	2.882	2.422	2.402	2.912	2.908	307	614
Anbotek Anbotek	1%	0.465	0.535	0.465	0.445	0.565	0.599	307	614
6cm	50%	1.432	1.872	1.542	1.542	1.622	1.663	307	614
Anboi	99%	2.357	2.817	2.357	2.337	2.827	2.887	307	614
otek Ani	1%	0.422	0.482	0.432	0.402	0.532	0.544	307	614
8cm	50%	1.396	1.846	1.516	1.516	1.606	1.604	307	614
Anbotek	99%	2.379	2.829	2.379	2.359	2.859	2.884	307	614
Aupoten	1%	0.385	0.475	0.425	0.365	0.505	0.460	307	614
10cm	50%	1.375	1.795	1.495	1.495	1.575	1.595	307	614
iek Yup	99%	2.345	2.775	2.335	2.315	2.805	2.824	307	614
por	1%	0.365	0.465	0.425	0.365	0.485	0.519	307 📈	614
12cm	50%	1.326	1.746	1.426	1.416	1.526	×1.511	307	614
All.	99%	2.364	2.794	2.324	2.324	2.814	2.789	307	614





E-Field St	trength		37		153		2101		
Test distance	Battery power	Test Position A	Test Positio n B	Test Positio n C	Test Positio n D	Test Positio n E	Test Positio n F	Referen ce Limit (V/m)	Limits Test (V/m)
Anbore	1%	0.358	0.458	0.418	0.358	0.488	0.457	307	614
14cm	50%	1.289	1.699	1.379	1.379	1.479	1.526	307	614
	99%	2.305	2.725	2.265	2.275	2.735	2.765	307	614
Vupo _{se} ,	1%	0.387	0.487	0.447	0.387	0.507	0.492	307	614
16cm	50%	1.319	1.719	1.399	1.409	1.489	1.457	307	614
	99%	2.308	2.728	2.278	2.268	2.748	2.802	307	614
otek P	1%	0.377	0.477	0.437	0.367	0.497	0.416	307	614
18cm	50%	1.286	1.696	1.386	1.396	1.476	1.460	307	614
Anbotek	99%	2.264	2.694	2.244	2.224	2.714	2.773	307	614
Anborek	1%	0.270	0.280	0.340	0.270	0.400	0.482	307	614
20cm	50%	1.349	1.739	1.429	1.439	1.539	1.535	307	614
	99%	2.238	2.678	2.228	2.208	2.698	2.741	307	614





H-Field S	trength								
Test distanc e	Battery power	Test Positio n A	Test Positio n B	Test Positio n C	Test Positio n D	Test Positio n E	Test Positio n F	Referenc e Limit (A/m)	Limits Test (A/m
Aupor	zek Ali	potek	EUT Ba	se suppor	t input + S	Standby	Vupo,	VI. upolek	AT
K An	1%	0.0293	0.0483	0.0513	0.0393	0.0473	0.0453	0.815	1.63
0cm	50%	0.4037	0.4737	0.3837	0.3637	0.5937	0.6038	0.815	1.63
inpo, otek	99%	0.4581	0.6381	0.5281	0.3281	0.3481	0.4006	0.815	1.63
Ana	EUT Base	support in	out + iPho	ne 13 ope	rating (10	% electric	quantity	worst case)	Vupo,
k pup	1% 🚾	0.119	0.138	0.140	0.127	0.141	0.028	0.815	1.63
0,2,4cm	50%	0.351	0.421	0.341	0.341	0.551	0.527	0.815	1.63
nbotek	99%	0.471	0.651	0.551	0.361	0.361	0.374	0.815	1.63
Anborek	1%	0.050	0.071	0.073	0.060	0.074	0.129	0.815	1.63
6cm	50%	0.385	0.435	0.355	0.375	0.585	0.525	0.815	1.63
Anbr	99%	0.434	0.574	0.504	0.294	0.324	0.357	0.815	1.63
ier b	1%	0.013	0.033	0.034	0.022	0.034	0.085	0.815	1.63
8cm	50%	0.256	0.356	0.276	0.286	0.506	0.515	0.815	1.63
	99%	0.356	0.526	0.446	0.246	0.266	0.276	0.815	1.63
Pur Upo	1% 🚾	0.108	0.128	0.127	0.117	0.127	0.130	0.815	1.63
10cm	50%	0.233	0.323	0.233	0.233	0.463	0.564	0.815	1.63
potek	99%	0.382	0.572	0.492	0.302	0.292	0.267	0.815	1.63
Anborek	1%	0.020	0.040	0.038	0.029	0.040	0.048	0.815	1.63
12cm	50%	0.263	0.363	0.263	0.263	0.513	0.537	0.815	1.63
Anbot	99%	0.385	0.575	0.505	0.325	0.315	0.286	0.815	1.63





H-Field S	trength								
Test distanc e	Battery power	Test Positio n A	Test Positio n B	Test Positio n C	Test Positio n D	Test Positio n E	Test Positio n F	Referenc e Limit (A/m)	Limits Test (A/m)
Anbot.	1%	0.023	0.042	0.041	0.032	0.042	0.082	0.815	1.63
14cm	50%	0.247	0.347	0.237	0.227	0.467	0.488	0.815	1.63
otek	99%	0.286	0.466	0.406	0.226	0.216	0.230	0.815	1.63
'upoter rek	1%	0.094	0.113	0.112	0.101	0.110	0.102	0.815	1.63
16cm	50%	0.181	0.261	0.161	0.151	0.401	0.497	0.815	1.63
Anbore	99%	0.316	0.516	0.446	0.276	0.266	0.272	0.815	1.63
stek l	1%	0.051	0.069	0.067	0.058	0.065	0.066	0.815	1.63
18cm	50%	0.244	0.334	0.224	0.214	0.464	0.446	0.815	1.63
Anbotek	99%	0.241	0.421	0.361	0.211	0.201	0.212	0.815	1.63
Aupore	1%	0.056	0.074	0.072	0.063	0.070	0.030	0.815	1.63
20cm	50%	0.239	0.319	0.219	0.209	0.449	0.469	0.815	1.63
botek	99%	0.312	0.492	0.422	0.282	0.272	0.217	0.815	1.63

Note:

- (1) Position E is top side.
- (2) All the situation (full load, half load and empty load) has been tested, only the worst situation (full load 15W) was recorded in the report.
- (3) All three axes the device has been tested, only the worst results reported.
- (4) All positions have been tested, only display photos of Position E and A in the report.





APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph MPE

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please	e refer to sepa	rated files Ap	pendix III	Internal Photog	graph
		Ans borek	Anbotek	Fnd of Report	, abotek

